Issue Classification

Application/C	ontrol	Νo
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ATKIN ET AL.

Applicant(s)/Patent Under Reexamination

Examiner

Art Unit

Neway, Samuel G

2626

ORIGINAL CLASS SUBCLASS						INTERNATIONAL CLASSIFICATION									
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CROSS REFERENCE(S)				G	0	6	F	9 / 44 (2006	5.0)						
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Neway, Samuel G 01-12-08 Smulb. Navey (Assistant Examiner) (Date)			St	DAVID HUDSPETH SUPERVISORY PATENT EXAMINER						Total Claims Allowed:					
				TECHNOLOGY CENTER 2600						O.G. Print Claim(s)				O.G. Print Figure	
(Legal Instruments (Date) Examiner)			(Primary Examiner) (Date)						1 8						